

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/562,760	WERNZ ET AL.	
Examiner		Art Unit		Page 1 of 1
TANYA NGO		2613		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,163,220 A	07-1979	Henningsen et al.	398/172
*	B	US-5,625,722 A	04-1997	Froberg et al.	385/1
*	C	US-5,799,119 A	08-1998	Rolland et al.	385/28
*	D	US-6,535,316 B1	03-2003	Mizuhara, Osamu	398/183
*	E	US-2003/0063698 A1	04-2003	Bontheron et al.	375/359
*	F	US-6,559,996 B1	05-2003	Miyamoto et al.	398/183
*	G	US-2005/0135816 A1	06-2005	Han et al.	398/188
*	H	US-2006/0008278 A1	01-2006	Kao et al.	398/188
*	I	US-2006/0245763 A1	11-2006	Ishida et al.	398/186
*	J	US-2008/0085127 A1	04-2008	NAKAMOTO, Hiroshi	398/185
*	K	US-7,433,604 B1	10-2008	Kim et al.	398/188
*	L	US-2009/0116849 A1	05-2009	Mizuguchi, Noriaki	398/188
*	M	US-2009/0304395 A1	12-2009	Hong et al.	398/189

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1528697 A1	05-2005	European Patent	LAZARO et al.	H04B 10/155
	O	EP 1659710 A1	05-2006	European Patent	ISHIDA et al.	H04B 10/04
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.